

# NT512D72S4PAKGU

512MB : 64M x 72

Low Profile Registered DDR SDRAM DIMM



## 184pin Low Profile Registered DDR SDRAM MODULE Based on 64Mx4 DDR SDRAM

### Features

- 64Mx72 Low Profile Registered DDR DIMM based on 64Mx4 DDR SDRAM
- JEDEC Standard 184-pin Dual In-Line Memory Module
- Error Check Correction (ECC) Support
- Phase-lock loop (PLL) clock driver to reduce loading
- Registered inputs with one-clock delay
- Performance:

|                                    | PC1600 | PC2100 |     |      |
|------------------------------------|--------|--------|-----|------|
| Speed Sort                         | -8B    | -75B   | -7K | Unit |
| DIMM CAS Latency*                  | 3      | 3.5    | 3   |      |
| f <sub>CK</sub> Clock Frequency    | 100    | 133    | 133 | MHz  |
| t <sub>CK</sub> Clock Cycle        | 10     | 7.5    | 7.5 | ns   |
| f <sub>DQ</sub> DQ Burst Frequency | 200    | 266    | 266 | MHz  |

- Intended for 100 MHz and 133 MHz applications
- Inputs and outputs are SSTL-2 compatible
- V<sub>DD</sub> = 2.5Volt ± 0.2, V<sub>DDQ</sub> = 2.5Volt ± 0.2
- SDRAMs have 4 internal banks for concurrent operation
- Differential clock inputs

\* One clock cycle added for registered DIMMs to account for input register.

- Data is read or written on both clock edges
- Bi-directional data strobe with one clock cycle preamble and one-half clock post-amble
- Address and control signals are fully synchronous to positive clock edge
- Programmable Operation:
  - Device  $\overline{\text{CAS}}$  Latency: 2, 2.5
  - Burst Type: Sequential or Interleave
  - Burst Length: 2, 4, 8
  - Operation: Burst Read and Write
- Auto Refresh (CBR) and Self Refresh Modes
- Automatic and controlled precharge commands
- 13/11/1 Addressing (row/column/bank)
- 7.8  $\mu$ s Max. Average Periodic Refresh Interval
- Serial Presence Detect
- Gold contacts
- SDRAMs in 66-pin TSOP Type II Package

### Description

NT512D72S4PAKGU is a Low Profile Registered 184-Pin 1U Double Data Rate (DDR) Synchronous DRAM Dual In-Line Memory Module (DIMM), organized as a one-bank 64Mx72 high-speed memory array. The module uses eighteen 64Mx4 DDR SDRAMs in 400 mil TSOP II packages. These DIMMs are manufactured using raw cards developed for broad industry use as reference designs. The use of these common design files minimizes electrical variation between suppliers. All NANYA DDR SDRAM DIMMs provide a high-performance, flexible 8-byte interface in a 5.25" long space-saving footprint.

The DIMM is intended for use in applications operating up to 133 MHz clock speeds and achieves high-speed data transfer rates of up to 266 MHz. Prior to any access operation, the device  $\overline{\text{CAS}}$  latency and burst type/ length/operation type must be programmed into the DIMM by address inputs A0-A12 and I/O inputs BA0 and BA1 using the mode register set cycle.

The DIMM uses serial presence-detect implemented via a serial 2,048-bit EEPROM using a standard IIC protocol. The first 128 bytes of serial PD data are programmed and locked during module assembly. The remaining 128 bytes are available for use by the customer.

### Ordering Information

| Part Number         | Speed                    |         |        | Organization | Leads | Power |
|---------------------|--------------------------|---------|--------|--------------|-------|-------|
| NT512D72S4PAKGU-7K  | 143MHz (7ns @ CL = 2.5)  | DDR266A | PC2100 | 64Mx72       | Gold  | 2.5V  |
|                     | 133MHz (7.5ns @ CL= 2)   |         |        |              |       |       |
| NT512D72S4PAKGU-75B | 133MHz (7.5ns @ CL= 2.5) | DDR266B | PC2100 |              |       |       |
|                     | 100MHz (10ns @ CL = 2)   |         |        |              |       |       |
| NT512D72S4PAKGU-8B  | 125MHz (8ns @ CL = 2.5)  | DDR200  | PC1600 |              |       |       |
|                     | 100MHz (10ns @ CL = 2)   |         |        |              |       |       |

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## Pin Description

|                       |                                |            |                                            |
|-----------------------|--------------------------------|------------|--------------------------------------------|
| CK0, $\overline{CK0}$ | Differential Clock Inputs      | DQ0-DQ63   | Data input/output                          |
| CKE0                  | Clock Enable                   | CB0-CB7    | Check Bit Data Input/Output                |
| $\overline{RAS}$      | Row Address Strobe             | DQS0-DQS17 | Bidirectional data strobes                 |
| $\overline{CAS}$      | Column Address Strobe          | VDD        | Power (2.5V)                               |
| $\overline{WE}$       | Write Enable                   | VDDQ       | Supply voltage for DQs (2.5V)              |
| $\overline{S0}$       | Chip Selects                   | VSS        | Ground                                     |
| A0-A9, A11, A12       | Address Inputs                 | NC         | No Connect                                 |
| A10/AP                | Address Input/Autoprecharge    | SCL        | Serial Presence Detect Clock Input         |
| BA0, BA1              | SDRAM Bank Address Inputs      | SDA        | Serial Presence Detect Data input/output   |
| $\overline{RESET}$    | Reset pin                      | SA0-2      | Serial Presence Detect Address Inputs      |
| VREF                  | Ref. Voltage for SSTL_2 inputs | VDDSPD     | Serial EEPROM positive power supply (2.5V) |
| VDDID                 | VDD Identification flag.       |            |                                            |

## Pinout

| Pin | Front              | Pin | Front | Pin | Front            | Pin | Back  | Pin | Back             | Pin | Back             |
|-----|--------------------|-----|-------|-----|------------------|-----|-------|-----|------------------|-----|------------------|
| 1   | VREF               | 32  | A5    | 62  | VDDQ             | 93  | VSS   | 124 | VSS              | 154 | $\overline{RAS}$ |
| 2   | DQ0                | 33  | DQ24  | 63  | $\overline{WE}$  | 94  | DQ4   | 125 | A6               | 155 | DQ45             |
| 3   | VSS                | 34  | VSS   | 64  | DQ41             | 95  | DQ5   | 126 | DQ28             | 156 | VDDQ             |
| 4   | DQ1                | 35  | DQ25  | 65  | $\overline{CAS}$ | 96  | VDDQ  | 127 | DQ29             | 157 | $\overline{S0}$  |
| 5   | DQS0               | 36  | DQS3  | 66  | VSS              | 97  | DQS9  | 128 | VDDQ             | 158 | NC               |
| 6   | DQ2                | 37  | A4    | 67  | DQS5             | 98  | DQ6   | 129 | DQS12            | 159 | DQS14            |
| 7   | VDD                | 38  | VDD   | 68  | DQ42             | 99  | DQ7   | 130 | A3               | 160 | VSS              |
| 8   | DQ3                | 39  | DQ26  | 69  | DQ43             | 100 | VSS   | 131 | DQ30             | 161 | DQ46             |
| 9   | NC                 | 40  | DQ27  | 70  | VDD              | 101 | NC    | 132 | VSS              | 162 | DQ47             |
| 10  | $\overline{RESET}$ | 41  | A2    | 71  | NC               | 102 | NC    | 133 | DQ31             | 163 | NC               |
| 11  | VSS                | 42  | VSS   | 72  | DQ48             | 103 | NC    | 134 | CB4              | 164 | VDDQ             |
| 12  | DQ8                | 43  | A1    | 73  | DQ49             | 104 | VDDQ  | 135 | CB5              | 165 | DQ52             |
| 13  | DQ9                | 44  | CB0   | 74  | VSS              | 105 | DQ12  | 136 | VDDQ             | 166 | DQ53             |
| 14  | DQS1               | 45  | CB1   | 75  | NC               | 106 | DQ13  | 137 | CK0              | 167 | NC               |
| 15  | VDDQ               | 46  | VDD   | 76  | NC               | 107 | DQS10 | 138 | $\overline{CK0}$ | 168 | VDD              |
| 16  | NC                 | 47  | DQS8  | 77  | VDDQ             | 108 | VDD   | 139 | VSS              | 169 | DQS15            |
| 17  | NC                 | 48  | A0    | 78  | DQS6             | 109 | DQ14  | 140 | DQS17            | 170 | DQ54             |
| 18  | VSS                | 49  | CB2   | 79  | DQ50             | 110 | DQ15  | 141 | A10              | 171 | DQ55             |
| 19  | DQ10               | 50  | VSS   | 80  | DQ51             | 111 | NC    | 142 | CB6              | 172 | VDDQ             |
| 20  | DQ11               | 51  | CB3   | 81  | VSS              | 112 | VDDQ  | 143 | VDDQ             | 173 | NC               |
| 21  | CKE0               | 52  | BA1   | 82  | VDDID            | 113 | NC    | 144 | CB7              | 174 | DQ60             |
| 22  | VDDQ               | KEY |       | 83  | DQ56             | 114 | DQ20  | KEY |                  | 175 | DQ61             |
| 23  | DQ16               | 53  | DQ32  | 84  | DQ57             | 115 | A12   | 145 | VSS              | 176 | VSS              |
| 24  | DQ17               | 54  | VDDQ  | 85  | VDD              | 116 | VSS   | 146 | DQ36             | 177 | DQS16            |
| 25  | DQS2               | 55  | DQ33  | 86  | DQS7             | 117 | DQ21  | 147 | DQ37             | 178 | DQ62             |
| 26  | VSS                | 56  | DQS4  | 87  | DQ58             | 118 | A11   | 148 | VDD              | 179 | DQ63             |
| 27  | A9                 | 57  | DQ34  | 88  | DQ59             | 119 | DQS11 | 149 | DQS13            | 180 | VDDQ             |
| 28  | DQ18               | 58  | VSS   | 89  | VSS              | 120 | VDD   | 150 | DQ38             | 181 | SA0              |
| 29  | A7                 | 59  | BA0   | 90  | NC               | 121 | DQ22  | 151 | DQ39             | 182 | SA1              |
| 30  | VDDQ               | 60  | DQ35  | 91  | SDA              | 122 | A8    | 152 | VSS              | 183 | SA2              |
| 31  | DQ19               | 61  | DQ40  | 92  | SCL              | 123 | DQ23  | 153 | DQ44             | 184 | VDDSPD           |

## Input/Output Functional Description

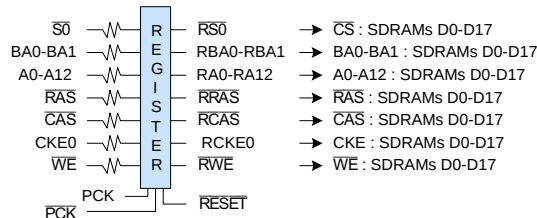
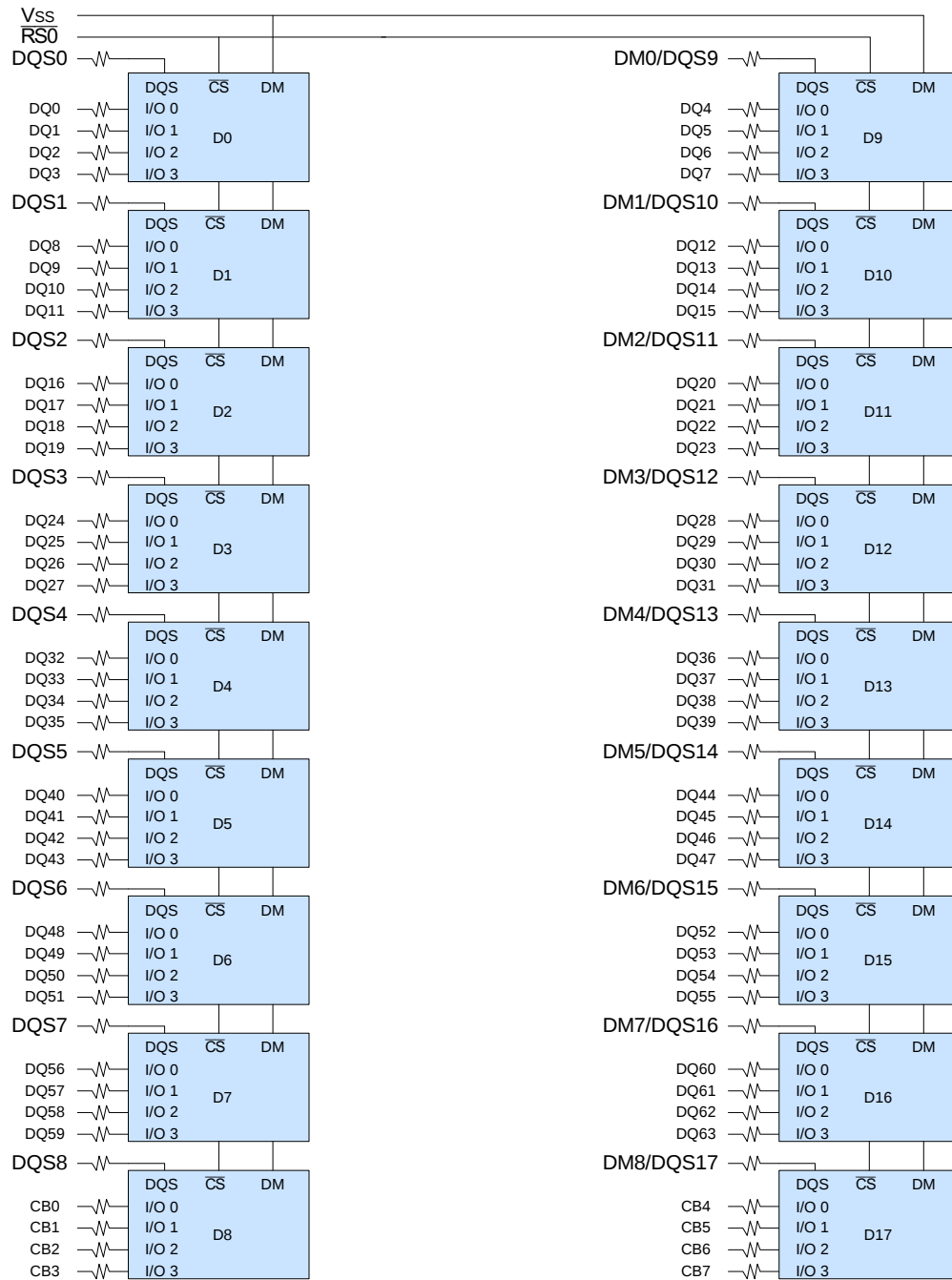
| Symbol                                                | Type      | Polarity                   | Function                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                         |
|-------------------------------------------------------|-----------|----------------------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|
| CK0                                                   | (SSTL)    | Positive Edge              | The positive line of the differential pair of system clock inputs which drives the input to the on-DIMM PLL. All the DDR SDRAM address and control inputs are sampled on the rising edge of their associated clocks.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
| $\overline{CK0}$                                      | (SSTL)    | Negative Edge              | The negative line of the differential pair of system clock inputs which drives the input to the on-DIMM PLL.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| CKE0                                                  | (SSTL)    | Active High                | Activates the SDRAM CK signal when high and deactivates the CK signal when low. By deactivating the clocks, CKE low initiates the Power Down mode, or the Self Refresh mode.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                     |
| $\overline{S0}$                                       | (SSTL)    | Active Low                 | Enables the associated SDRAM command decoder when low and disables the command decoder when high. When the command decoder is disabled, new commands are ignored but previous operations continue.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                               |
| $\overline{RAS}$ , $\overline{CAS}$ , $\overline{WE}$ | (SSTL)    | Active Low                 | When sampled at the positive rising edge of the clock, $\overline{RAS}$ , $\overline{CAS}$ , $\overline{WE}$ define the operation to be executed by the SDRAM.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| VREF                                                  | Supply    |                            | Reference voltage for SSTL-2 inputs                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                              |
| VDDQ                                                  | Supply    |                            | Isolated power supply for the DDR SDRAM output buffers to provide improved noise immunity                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| BA0, BA1                                              | (SSTL)    | -                          | Selects which SDRAM bank is to be active.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| A0 - A9<br>A10/AP<br>A11, A12                         | (SSTL)    | -                          | During a Bank Activate command cycle, A0-A12 defines the row address (RA0-RA12) when sampled at the rising clock edge.<br>During a Read or Write command cycle, A0-A9, A11 defines the column address (CA0-CA10) when sampled at the rising clock edge. In addition to the column address, AP is used to invoke Autoprecharge operation at the end of the Burst Read or Write cycle. If AP is high, autoprecharge is selected and BA0/BA1 define the bank to be precharged. If AP is low, autoprecharge is disabled.<br>During a Precharge command cycle, AP is used in conjunction with BA0/BA1 to control which bank(s) to precharge. If AP is high all 4 banks will be precharged regardless of the state of BA0/BA1. If AP is low, then BA0/BA1 are used to define which bank to pre-charge. |
| DQ0 - DQ63                                            | (SSTL)    | -                          | Data and Check Bit input/output pins operate in the same manner as on conventional DRAMs.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                        |
| DQ0 - DQ63<br>CB0 - CB7                               | (SSTL)    | Active High                | Data and Check Bit Input/Output pins. Check bits are only applicable on the x72 DIMM configurations.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |
| VDD, VSS                                              | Supply    |                            | Power and ground for the DDR SDRAM input buffers and core logic                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| DQS0 - DQS17                                          | (SSTL)    | Negative and Positive Edge | Data strobe for input and output data                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                            |
| RESET                                                 | (LVC-MOS) | Active Low                 |                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                  |
| SA0 - SA2                                             |           | -                          | Address inputs. Connected to either VDD or VSS on the system board to configure the Serial Presence Detect EEPROM address.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                       |
| SDA                                                   |           | -                          | This bi-directional pin is used to transfer data into or out of the SPD EEPROM. A resistor must be connected from the SDA bus line to VDD to act as a pullup.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                    |
| SCL                                                   |           | -                          | This signal is used to clock data into and out of the SPD EEPROM. A resistor may be connected from the SCL bus line to VDD to act as a pullup.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                   |
| VDDSPD                                                | Supply    |                            | Serial EEPROM positive power supply.                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                                             |

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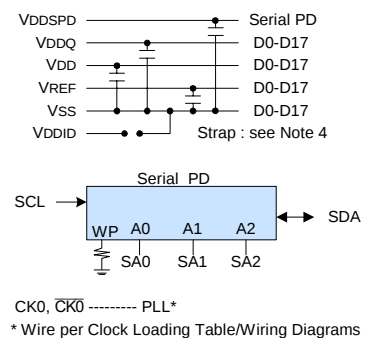
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## Functional Block Diagram (1 Bank, 64Mx4 DDR SDRAMs)



- Notes :
1. DQ-to-I/O wiring may be changed within a byte.
  2. DQ/DQS/DM/CKE/CS relationships are maintained as shown.
  3. DQ/DQS resistors are 22 Ohms.
  4.  $V_{DDID}$  strap connections (for memory device  $V_{DD}$ ,  $V_{DDQ}$ ):  
STRAP OUT (OPEN):  $V_{DD} = V_{DDQ}$   
STRAP IN ( $V_{SS}$ ):  $V_{DD}$  is not equal to  $V_{DDQ}$
  5. Address and control resistors are 22 Ohms.



CK0, CK0 ..... PLL\*  
\* Wire per Clock Loading Table/Wiring Diagrams

**NT512D72S4PAKGU****512MB : 64M x 72****Low Profile Registered DDR SDRAM DIMM****Serial Presence Detect -- Part 1 of 2***64Mx72 1 BANK REGISTERED DDR SDRAM DIMM based on 64Mx4, 4Banks, 8K Refresh, 2.5V DDR SDRAMs with SPD*

| Byte  | Description                                             | SPD Entry Value                   |                 |               | Serial PD Data Entry (Hexadecimal) |                 |               | Note |
|-------|---------------------------------------------------------|-----------------------------------|-----------------|---------------|------------------------------------|-----------------|---------------|------|
|       |                                                         | DDR266A<br>-7K                    | DDR266B<br>-75B | DDR200<br>-8B | DDR266A<br>-7K                     | DDR266B<br>-75B | DDR200<br>-8B |      |
| 0     | Number of Serial PD Bytes Written during Production     | 128                               |                 |               | 80                                 |                 |               |      |
| 1     | Total Number of Bytes in Serial PD device               | 256                               |                 |               | 08                                 |                 |               |      |
| 2     | Fundamental Memory Type                                 | SDRAM DDR                         |                 |               | 07                                 |                 |               |      |
| 3     | Number of Row Addresses on Assembly                     | 13                                |                 |               | 0D                                 |                 |               |      |
| 4     | Number of Column Addresses on Assembly                  | 11                                |                 |               | 0B                                 |                 |               |      |
| 5     | Number of DIMM Bank                                     | 1                                 |                 |               | 01                                 |                 |               |      |
| 6     | Data Width of Assembly                                  | X72                               |                 |               | 48                                 |                 |               |      |
| 7     | Data Width of Assembly (cont')                          | X72                               |                 |               | 00                                 |                 |               |      |
| 8     | Voltage Interface Level of this Assembly                | SSTL 2.5V                         |                 |               | 04                                 |                 |               |      |
| 9     | DDR SDRAM Device Cycle Time at CL=2.5                   | 7ns                               | 7.5ns           | 8ns           | 70                                 | 75              | 80            |      |
| 10    | DDR SDRAM Device Access Time from Clock at CL=2.5       | 0.75ns                            | 0.75ns          | 0.8ns         | 75                                 | 75              | 80            |      |
| 11    | DIMM Configuration Type                                 | ECC                               |                 |               | 02                                 |                 |               |      |
| 12    | Refresh Rate/Type                                       | 7.8us / SR                        |                 |               | 82                                 |                 |               |      |
| 13    | Primary DDR SDRAM Width                                 | X4                                |                 |               | 04                                 |                 |               |      |
| 14    | Error Checking DDR SDRAM Device Width                   | X4                                |                 |               | 04                                 |                 |               |      |
| 15    | DDR SDRAM Device Attr: Min CLK Delay, Random Col Access | 1 Clock                           |                 |               | 01                                 |                 |               |      |
| 16    | DDR SDRAM Device Attributes: Burst Length Supported     | 2, 4, 8                           |                 |               | 0E                                 |                 |               |      |
| 17    | DDR SDRAM Device Attributes: Number of Device Banks     | 4                                 |                 |               | 04                                 |                 |               |      |
| 18    | DDR SDRAM Device Attributes: CAS Latencies Supported    | 2/2.5                             | 2/2.5           | 2/2.5         | 0C                                 | 0C              | 0C            |      |
| 19    | DDR SDRAM Device Attributes: CS Latency                 | 0                                 |                 |               | 01                                 |                 |               |      |
| 20    | DDR SDRAM Device Attributes: WE Latency                 | 1                                 |                 |               | 02                                 |                 |               |      |
| 21    | DDR SDRAM Device Attributes:                            | Differential Clock, PLL, REGISTER |                 |               | 26                                 |                 |               |      |
| 22    | DDR SDRAM Device Attributes: General                    | +/-0.2V Voltage Tolerance         |                 |               | 00                                 |                 |               |      |
| 23    | Minimum Clock Cycle at CL=2                             | 7.5ns                             | 10ns            | 10ns          | 75                                 | A0              | A0            |      |
| 24    | Maximum Data Access Time from Clock at CL=2             | 0.75ns                            | 0.75ns          | 0.8ns         | 75                                 | 75              | 80            |      |
| 25    | Minimum Clock Cycle Time at CL=1                        | N/A                               |                 |               | 00                                 |                 |               |      |
| 26    | Maximum Data Access Time from Clock at CL=1             | N/A                               |                 |               | 00                                 |                 |               |      |
| 27    | Minimum Row Precharge Time (trP)                        | 20ns                              | 20ns            | 30ns          | 50                                 | 50              | 78            |      |
| 28    | Minimum Row Active to Row Active delay (trRD)           | 15ns                              | 15ns            | 15ns          | 3C                                 | 3C              | 3C            |      |
| 29    | Minimum RAS to CAS delay (trCD)                         | 20ns                              | 20ns            | 30ns          | 50                                 | 50              | 78            |      |
| 30    | Minimum RAS Pulse Width (trAS)                          | 45ns                              | 45ns            | 50ns          | 2D                                 | 2D              | 32            |      |
| 31    | Module Bank Density                                     | 512MB                             |                 |               | 80                                 |                 |               |      |
| 32    | Address and Command Setup Time Before Clock             | 0.9ns                             | 0.9ns           | 1.1ns         | 90                                 | 90              | B0            |      |
| 33    | Address and Command Hold Time After Clock               | 0.9ns                             | 0.9ns           | 1.1ns         | 90                                 | 90              | B0            |      |
| 34    | Data Input Setup Time Before Clock                      | 0.5ns                             | 0.5ns           | 0.6ns         | 50                                 | 50              | 60            |      |
| 35    | Data Input Hold Time After Clock                        | 0.5ns                             | 0.5ns           | 0.6ns         | 50                                 | 50              | 60            |      |
| 36-61 | Reserved                                                | Undefined                         |                 |               | 00                                 |                 |               |      |
| 62    | SPD Revision                                            | Initial                           | Initial         | Initial       | 00                                 | 00              | 00            |      |
| 63    | Checksum Data                                           |                                   |                 |               | E0                                 | 10              | E6            |      |

**REV 1.1**

12/2002



# NT512D72S4PAKGU

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## Serial Presence Detect -- Part 2 of 2

64Mx72 1 BANK REGISTERED DDR SDRAM DIMM based on 64Mx4, 4Banks, 8K Refresh, 2.5V DDR SDRAMs with SPD

| Byte   | Description                   | SPD Entry Value |                 |               | Serial PD Data Entry (Hexadecimal) |                 |               | Note |
|--------|-------------------------------|-----------------|-----------------|---------------|------------------------------------|-----------------|---------------|------|
|        |                               | DDR266A<br>-7K  | DDR266B<br>-75B | DDR200<br>-8B | DDR266A<br>-7K                     | DDR266B<br>-75B | DDR200<br>-8B |      |
| 64-71  | Manufacturer's JEDEC ID Code  | NANYA           |                 |               | 7F7F7F0B00000000                   |                 |               |      |
| 72     | Module Manufacturing Location | N/A             |                 |               | 00                                 |                 |               |      |
| 73-90  | Module Part number            | N/A             | N/A             | N/A           | 00                                 | 00              | 00            |      |
| 91-92  | Module Revision Code          | N/A             |                 |               | 00                                 |                 |               |      |
| 93-94  | Module Manufacturing Data     | Year/Week Code  |                 |               | yy/ww                              |                 |               | 1, 2 |
| 95-98  | Module Serial Number          | Serial Number   |                 |               | 00                                 |                 |               |      |
| 99-255 | Reserved                      | Undefined       |                 |               | 00                                 |                 |               |      |

1. yy= Binary coded decimal year code, 0-99(Decimal), 00-63(Hex)
2. ww= Binary coded decimal year code, 01-52(Decimal), 01-34(Hex)

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## Absolute Maximum Ratings

| Symbol            | Parameter                              | Rating           | Units |
|-------------------|----------------------------------------|------------------|-------|
| $V_{IN}, V_{OUT}$ | Voltage on I/O pins relative to Vss    | -0.5 to VDDQ+0.5 | V     |
| $V_{IN}$          | Voltage on Input relative to Vss       | -0.5 to +2.7     | V     |
| $V_{DD}$          | Voltage on VDD supply relative to Vss  | -0.5 to +2.7     | V     |
| $V_{DDQ}$         | Voltage on VDDQ supply relative to Vss | -0.5 to +2.7     | V     |
| $T_A$             | Operating Temperature (Ambient)        | 0 to +70         | °C    |
| $T_{STG}$         | Storage Temperature (Plastic)          | -55 to +150      | °C    |
| $P_D$             | Power Dissipation                      | 18               | W     |
| $I_{OUT}$         | Short Circuit Output Current           | 50               | mA    |

**Note:** Stresses greater than those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is stress rating only, and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

## Capacitance

| Parameter                                                                                                          | Symbol | Max. | Units | Notes |
|--------------------------------------------------------------------------------------------------------------------|--------|------|-------|-------|
| Input Capacitance: CK0, $\overline{CK0}$                                                                           | Ci1    | TBD  | pF    | 1     |
| Input Capacitance: A0-A12, BA0, BA1, $\overline{WE}$ , $\overline{RAS}$ , $\overline{CAS}$ , CKE0, $\overline{S0}$ | Ci2    | TBD  | pF    | 1     |
| Input Capacitance: $\overline{RESET}$                                                                              | Ci3    | TBD  | pF    | 1     |
| Input Capacitance: SA0-SA2, SCL                                                                                    | Ci4    | TBD  | pF    | 1     |
| Input/Output Capacitance DQ0-63; DQS0-17, CB0-7                                                                    | CiO1   | TBD  | pF    | 1, 2  |
| Input/Output Capacitance: SDA                                                                                      | CiO3   | TBD  | pF    |       |

1. VDDQ = VDD = 2.5V  $\pm$  0.2V, f = 100 MHz, TA = 25 °C, VOUT (DC) = VDDQ/2, VOUT (Peak to Peak) = 0.2V.
2. DM inputs are grouped with I/O pins reflecting the fact that they are matched in loading to DQ and DQS to facilitate trace matching at the board level.

## DC Electrical Characteristics and Operating Conditions

(TA = 0 °C ~ 70 °C; V<sub>DDQ</sub> = 2.5V ± 0.2V; V<sub>DD</sub> = 2.5V ± 0.2V, See AC Characteristics)

| Symbol                             | Parameter                                                                                                          | Min                     | Max                     | Units | Notes |
|------------------------------------|--------------------------------------------------------------------------------------------------------------------|-------------------------|-------------------------|-------|-------|
| V <sub>DD</sub>                    | Supply Voltage                                                                                                     | 2.3                     | 2.7                     | V     | 1     |
| V <sub>DDQ</sub>                   | I/O Supply Voltage                                                                                                 | 2.3                     | 2.7                     | V     | 1     |
| V <sub>SS</sub> , V <sub>SSQ</sub> | Supply Voltage, I/O Supply Voltage                                                                                 | 0                       | 0                       | V     |       |
| V <sub>REF</sub>                   | I/O Reference Voltage                                                                                              | 0.49 x V <sub>DDQ</sub> | 0.51 x V <sub>DDQ</sub> | V     | 1, 2  |
| V <sub>TT</sub>                    | I/O Termination Voltage (System)                                                                                   | V <sub>REF</sub> - 0.04 | V <sub>REF</sub> + 0.04 | V     | 1, 3  |
| V <sub>IH</sub> (DC)               | Input High (Logic1) Voltage                                                                                        | V <sub>REF</sub> + 0.15 | V <sub>DDQ</sub> + 0.3  | V     | 1     |
| V <sub>IL</sub> (DC)               | Input Low (Logic0) Voltage                                                                                         | -0.3                    | V <sub>REF</sub> - 0.15 | V     | 1     |
| V <sub>IN</sub> (DC)               | Input Voltage Level, CK and $\overline{CK}$ Inputs                                                                 | -0.3                    | V <sub>DDQ</sub> + 0.3  | V     | 1     |
| V <sub>ID</sub> (DC)               | Input Differential Voltage, CK and $\overline{CK}$ Inputs                                                          | 0.30                    | V <sub>DDQ</sub> + 0.6  | V     | 1, 4  |
| I <sub>I</sub>                     | Input Leakage Current<br>Any input 0V ≤ V <sub>IN</sub> ≤ V <sub>DD</sub> ; (All other pins not under test = 0V)   | -5                      | 5                       | uA    | 1     |
| I <sub>OZ</sub>                    | Output Leakage Current<br>(DQs are disabled; 0V ≤ V <sub>out</sub> ≤ V <sub>DDQ</sub> )                            | -5                      | 5                       | uA    | 1     |
| I <sub>OH</sub>                    | Output High Current<br>(V <sub>OUT</sub> = V <sub>DDQ</sub> - 0.373V, min V <sub>REF</sub> , min V <sub>TT</sub> ) | -16.8                   | -                       | mA    | 1     |
| I <sub>OL</sub>                    | Output Low Current<br>(V <sub>OUT</sub> = 0.373, max V <sub>REF</sub> , max V <sub>TT</sub> )                      | 16.8                    | -                       | mA    | 1     |

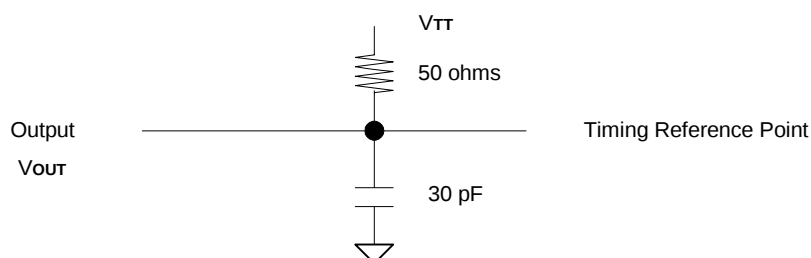
- Inputs are not recognized as valid until V<sub>REF</sub> stabilizes.
- V<sub>REF</sub> is expected to be equal to 0.5 V<sub>DDQ</sub> of the transmitting device, and to track variations in the DC level of the same. Peak-to-peak noise on V<sub>REF</sub> may not exceed 2% of the DC value.
- V<sub>TT</sub> is not applied directly to the DIMM. V<sub>TT</sub> is a system supply for signal termination resistors, is expected to be set equal to V<sub>REF</sub>, and must track variations in the DC level of V<sub>REF</sub>.
- V<sub>ID</sub> is the magnitude of the difference between the input level on CK and the input level on  $\overline{CK}$ .

## AC Characteristics

(Notes 1-5 apply to the following Tables; Electrical Characteristics and DC Operating Conditions, AC Operating Conditions, Operating, Standby, and Refresh Currents, and Electrical Characteristics and AC Timing.)

1. All voltages referenced to VSS.
2. Tests for AC timing, I<sub>DD</sub>, and electrical, AC and DC characteristics, may be conducted at nominal reference/supply voltage levels, but the related specifications and device operation are guaranteed for the full voltage range specified.
3. Outputs measured with equivalent load. Refer to the AC Output Load Circuit below.
4. AC timing and I<sub>DD</sub> tests may use a V<sub>IL</sub> to V<sub>IH</sub> swing of up to 1.5V in the test environment, but input timing is still referenced to V<sub>REF</sub> (or to the crossing point for CK, CK), and parameter specifications are guaranteed for the specified AC input levels under normal use conditions. The minimum slew rate for the input signals is 1V/ns in the range between V<sub>IL</sub> (AC) and V<sub>IH</sub> (AC) unless otherwise specified.
5. The AC and DC input level specifications are as defined in the SSTL\_2 Standard (i.e. the receiver effectively switches as a result of the signal crossing the AC input level, and remains in that state as long as the signal does not ring back above (below) the DC input LOW (HIGH) level.

## AC Output Load Circuits



## AC Operating Conditions

(TA = 0 °C ~ 70 °C; V<sub>DDQ</sub> = 2.5V ± 0.2V; V<sub>DD</sub> = 2.5V ± 0.2V, See AC Characteristics)

| Symbol               | Parameter/Condition                                                        | Min                          | Max                          | Unit | Notes   |
|----------------------|----------------------------------------------------------------------------|------------------------------|------------------------------|------|---------|
| V <sub>IH</sub> (AC) | Input High (Logic 1) Voltage                                               | V <sub>REF</sub> + 0.31      | -                            | V    | 1, 2    |
| V <sub>IL</sub> (AC) | Input Low (Logic 0) Voltage                                                | -                            | V <sub>REF</sub> - 0.31      | V    | 1, 2    |
| V <sub>ID</sub> (AC) | Input Differential Voltage, CK and $\overline{CK}$ Inputs                  | 0.7                          | V <sub>DDQ</sub> + 0.6       | V    | 1, 2, 3 |
| V <sub>IX</sub> (AC) | Input Differential Pair Cross Point Voltage, CK and $\overline{CK}$ Inputs | 0.5 x V <sub>DDQ</sub> - 0.2 | 0.5 x V <sub>DDQ</sub> + 0.2 | V    | 1, 2, 4 |

1. Input slew rate = 1V/ ns.
2. Inputs are not recognized as valid until V<sub>REF</sub> stabilizes.
3. V<sub>ID</sub> is the magnitude of the difference between the input level on CK and the input level on  $\overline{CK}$ .
4. The value of V<sub>IX</sub> is expected to equal 0.5 x V<sub>DDQ</sub> of the transmitting device and must track variations in the DC level of the same.

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512MB : 64M x 72

Low Profile Registered DDR SDRAM DIMM

## Operating, Standby, and Refresh Currents

(TA = 0 °C ~ 70 °C; V<sub>DDQ</sub> = 2.5V ± 0.2V; V<sub>DD</sub> = 2.5V ± 0.2V, See AC Characteristics)

| Symbol                                                                                                                                                                                                                                                                                                    | Parameter/Condition                                                                                                                                                                                                                                                                                             | PC2100<br>(-7K/-75B) | PC1600<br>(-8K) | Unit | Notes   |
|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------------------|-----------------|------|---------|
| I <sub>DD0</sub>                                                                                                                                                                                                                                                                                          | Operating Current: one bank; active/precharge; t <sub>RC</sub> = t <sub>RC</sub> (MIN); t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM, and DQS inputs changing twice per clock cycle; address and control inputs changing once per clock cycle                                                                | 2400                 | 1960            | mA   | 1, 2    |
| I <sub>DD1</sub>                                                                                                                                                                                                                                                                                          | Operating Current: one bank; active/read/precharge; Burst = 2; t <sub>RC</sub> = t <sub>RC</sub> (MIN); CL=2.5; t <sub>CK</sub> = t <sub>CK</sub> (MIN); I <sub>OUT</sub> = 0mA; address and control inputs changing once per clock cycle                                                                       | 2800                 | 2230            | mA   | 1, 2    |
| I <sub>DD2P</sub>                                                                                                                                                                                                                                                                                         | Precharge Power-Down Standby Current: all banks idle; power-down mode; CKE ≤ V <sub>IL</sub> (MAX); t <sub>CK</sub> = t <sub>CK</sub> (MIN)                                                                                                                                                                     | 1000                 | 800             | mA   | 1, 2    |
| I <sub>DD2N</sub>                                                                                                                                                                                                                                                                                         | Idle Standby Current: CS ≥ V <sub>IH</sub> (MIN); all banks idle; CKE ≥ V <sub>IH</sub> (MIN); t <sub>CK</sub> = t <sub>CK</sub> (MIN); address and control inputs changing once per clock cycle                                                                                                                | 1300                 | 1040            | mA   | 1, 2    |
| I <sub>DD3P</sub>                                                                                                                                                                                                                                                                                         | Active Power-Down Standby Current: one bank active; power-down mode; CKE ≤ V <sub>IL</sub> (MAX); t <sub>CK</sub> = t <sub>CK</sub> (MIN)                                                                                                                                                                       | 1000                 | 800             | mA   | 1, 2    |
| I <sub>DD3N</sub>                                                                                                                                                                                                                                                                                         | Active Standby Current: one bank; active/precharge; CS ≥ V <sub>IH</sub> (MIN); CKE ≥ V <sub>IH</sub> (MIN); t <sub>RC</sub> = t <sub>RAS</sub> (MAX); t <sub>CK</sub> = t <sub>CK</sub> (MIN); DQ, DM, and DQS inputs changing twice per clock cycle; address and control inputs changing once per clock cycle | 1700                 | 1400            | mA   | 1, 2    |
| I <sub>DD4R</sub>                                                                                                                                                                                                                                                                                         | Operating Current: one bank; Burst = 2; reads; continuous burst; address and control inputs changing once per clock cycle; DQ and DQS outputs changing twice per clock cycle; CL = 2.5; t <sub>CK</sub> = t <sub>CK</sub> (MIN); I <sub>OUT</sub> = 0mA                                                         | 3800                 | 3000            | mA   | 1, 2    |
| I <sub>DD4W</sub>                                                                                                                                                                                                                                                                                         | Operating Current: one bank; Burst = 2; writes; continuous burst; address and control inputs changing once per clock cycle; DQ and DQS inputs changing twice per clock cycle; CL=2.5; t <sub>CK</sub> = t <sub>CK</sub> (MIN)                                                                                   | 3000                 | 2400            | mA   | 1, 2    |
| I <sub>DD5</sub>                                                                                                                                                                                                                                                                                          | Auto-Refresh Current: t <sub>RC</sub> = t <sub>RF</sub> (MIN)                                                                                                                                                                                                                                                   | 4100                 | 3280            | mA   | 1, 2, 4 |
| I <sub>DD6</sub>                                                                                                                                                                                                                                                                                          | Self-Refresh Current: CKE ≤ 0.2V                                                                                                                                                                                                                                                                                | 100                  | 100             | mA   | 1, 2    |
| I <sub>DD7</sub>                                                                                                                                                                                                                                                                                          | Operating Current: four bank; four bank interleaving with BL = 4, address and control inputs randomly changing; 50% of data changing at every transfer; t <sub>RC</sub> = t <sub>RC</sub> (min); I <sub>OUT</sub> = 0mA.                                                                                        | 5800                 | 4700            | mA   | 1, 2    |
| 1. I <sub>DD</sub> specifications are tested after the device is properly initialized.<br>2. Input slew rate = 1V/ ns.<br>3. Enables on-chip refresh and address counters.<br>4. Current at 7.8 μs is time-averaged value of I <sub>DD5</sub> at t <sub>RF</sub> (MIN) and I <sub>DD2P</sub> over 7.8 μs. |                                                                                                                                                                                                                                                                                                                 |                      |                 |      |         |

## AC Timing Specifications for DDR SDRAM Devices Used on Module

(TA = 0 °C ~ 70 °C; V<sub>DDQ</sub> = 2.5V ± 0.2V; V<sub>DD</sub> = 2.5V ± 0.2V, See AC Characteristics) (Part 1 of 2)

| Symbol  | Parameter                                                                                    |        | -7K              |       | -75B             |       | -8B              |      | Unit | Notes                |
|---------|----------------------------------------------------------------------------------------------|--------|------------------|-------|------------------|-------|------------------|------|------|----------------------|
|         |                                                                                              |        | Min.             | Max.  | Min.             | Max.  | Min.             | Max. |      |                      |
| tAC     | DQ output access time from CK/CK̄                                                            |        | -0.75            | +0.75 | -0.75            | +0.75 | -0.8             | +0.8 | ns   | 1-4                  |
| tdQSK   | DQS output access time from CK/CK̄                                                           |        | -0.75            | +0.75 | -0.75            | +0.75 | -0.8             | +0.8 | ns   | 1-4                  |
| tCH     | CK high-level width                                                                          |        | 0.45             | 0.55  | 0.45             | 0.55  | 0.45             | 0.55 | tCK  | 1-4                  |
| tCL     | CK low-level width                                                                           |        | 0.45             | 0.55  | 0.45             | 0.55  | 0.45             | 0.55 | tCK  | 1-4                  |
| tCK     | Clock cycle time                                                                             | CL=2.5 | 7                | 12    | 7.5              | 12    | 8                | 12   | ns   | 1-4                  |
| tCK     |                                                                                              | CL=2   | 7.5              | 12    | 10               | 12    | 10               | 12   | ns   | 1-4                  |
| tdH     | DQ and DM input hold time                                                                    |        | 0.5              |       | 0.5              |       | 0.6              |      | ns   | 1-4,<br>15, 16       |
| tdS     | DQ and DM input setup time                                                                   |        | 0.5              |       | 0.5              |       | 0.6              |      | ns   | 1-4,<br>15, 16       |
| tdIPW   | DQ and DM input pulse width (each input)                                                     |        | 1.75             |       | 1.75             |       | 2                |      | ns   | 1-4                  |
| thZ     | Data-out high-impedance time from CK/CK̄                                                     |        | -0.75            | +0.75 | -0.75            | +0.75 | -0.8             | +0.8 | ns   | 1-4, 5               |
| tlZ     | Data-out low-impedance time from CK/CK̄                                                      |        | -0.75            | +0.75 | -0.75            | +0.75 | -0.8             | +0.8 | ns   | 1-4, 5               |
| tdQSQ   | DQS-DQ skew (DQS & associated DQ signals)                                                    |        |                  | 0.5   |                  | 0.5   |                  | 0.6  | ns   | 1-4                  |
| tdQSQA  | DQS-DQ skew (DQS & all DQ signals)                                                           |        |                  | 0.5   |                  | 0.5   |                  | 0.6  | ns   | 1-4                  |
| tHP     | Minimum half clk period for any given cycle; defined by clk high (tCH) or clk low (tCL) time |        | tCH<br>or<br>tCL |       | tCH<br>or<br>tCL |       | tCH<br>or<br>tCL |      | tCK  | 1-4                  |
| tQH     | Data output hold time from DQS                                                               |        | tHP -<br>0.75ns  |       | tHP -<br>0.75ns  |       | tHP -<br>1.0ns   |      | tCK  | 1-4                  |
| tdQSS   | Write command to 1st DQS latching transition                                                 |        | 0.75             | 1.25  | 0.75             | 1.25  | 0.75             | 1.25 | tCK  | 1-4                  |
| tdQSL,H | DQS input low (high) pulse width (write cycle)                                               |        | 0.35             |       | 0.35             |       | 0.35             |      | tCK  | 1-4                  |
| tdSS    | DQS falling edge to CK setup time (write cycle)                                              |        | 0.2              |       | 0.2              |       | 0.2              |      | tCK  | 1-4                  |
| tdSH    | DQS falling edge hold time from CK (write cycle)                                             |        | 0.2              |       | 0.2              |       | 0.2              |      | tCK  | 1-4                  |
| tMRD    | Mode register set command cycle time                                                         |        | 14               |       | 15               |       | 16               |      | ns   | 1-4                  |
| tWPRES  | Write preamble setup time                                                                    |        | 0                |       | 0                |       | 0                |      | ns   | 1-4, 7               |
| tWPST   | Write postamble                                                                              |        | 0.40             | 0.60  | 0.40             | 0.60  | 0.40             | 0.60 | tCK  | 1-4, 6               |
| tWPRE   | Write preamble                                                                               |        | 0.25             |       | 0.25             |       | 0.25             |      | tCK  | 1-4                  |
| tIH     | Address and control input hold time (fast slew rate)                                         |        | 0.9              |       | 1.1              |       | 1.1              |      | ns   | 2-4,<br>9, 11,<br>12 |
| tIS     | Address and control input setup time (fast slew rate)                                        |        | 0.9              |       | 1.1              |       | 1.1              |      | ns   | 2-4,<br>9, 11,<br>12 |
| tIH     | Address and control input hold time (slow slew rate)                                         |        | 1.0              |       | 1.1              |       | 1.1              |      | ns   | 2-4,<br>10-12,<br>14 |

## AC Timing Specifications for DDR SDRAM Devices Used on Module

(TA = 0 °C ~ 70 °C; V<sub>DDQ</sub> = 2.5V ± 0.2V; V<sub>DD</sub> = 2.5V ± 0.2V, See AC Characteristics) (Part 2 of 2)

| Symbol | Parameter                                            | -7K                                 |         | -75B                                |         | -8B                                 |         | Unit | Notes          |
|--------|------------------------------------------------------|-------------------------------------|---------|-------------------------------------|---------|-------------------------------------|---------|------|----------------|
|        |                                                      | Min.                                | Max.    | Min.                                | Max.    | Min.                                | Max.    |      |                |
| tIS    | Address and control input setup time (slow slewrate) | 1.0                                 |         | 1.0                                 |         | 1.1                                 |         | ns   | 2-4, 10-12, 14 |
| tIPW   | Input pulse width                                    | 2.2                                 |         | 2.2                                 |         |                                     | -       | ns   | 2-4, 12        |
| trPRE  | Read preamble                                        | 0.9                                 | 1.1     | 0.9                                 | 1.1     | 0.9                                 | 1.1     | tCK  | 1-4            |
| trPST  | Read postamble                                       | 0.40                                | 0.60    | 0.40                                | 0.60    | 0.40                                | 0.60    | tCK  | 1-4            |
| trAS   | Active to Precharge command                          | 45                                  | 120,000 | 45                                  | 120,000 | 50                                  | 120,000 | ns   | 1-4            |
| trC    | Active to Active/Auto-refresh command period         | 65                                  |         | 65                                  |         | 70                                  |         | ns   | 1-4            |
| trFC   | Auto-refresh to Active/Auto-refresh command period   | 75                                  |         | 75                                  |         | 80                                  |         | ns   | 1-4            |
| trCD   | Active to Read or Write delay                        | 20                                  |         | 20                                  |         | 20                                  |         | ns   | 1-4            |
| trAP   | Active to Read Command with Autoprecharge            | 20                                  |         | 20                                  |         | 20                                  |         | ns   | 1-4            |
| trP    | Precharge command period                             | 20                                  |         | 20                                  |         | 20                                  |         | ns   | 1-4            |
| trRD   | Active bank A to Active bank B command               | 15                                  |         | 15                                  |         | 15                                  |         | ns   | 1-4            |
| tWR    | Write recovery time                                  | 15                                  |         | 15                                  |         | 15                                  |         | ns   | 1-4            |
| tdAL   | Auto precharge write recovery + precharge time       | $(t_{WR}/t_{CK}) + (t_{RP}/t_{CK})$ |         | $(t_{WR}/t_{CK}) + (t_{RP}/t_{CK})$ |         | $(t_{WR}/t_{CK}) + (t_{RP}/t_{CK})$ |         | tCK  | 1-4, 13        |
| twTR   | Internal write to read command delay                 | 1                                   |         | 1                                   |         | 1                                   |         | tCK  | 1-4            |
| tpDEX  | Power down exit time                                 | 7.5                                 |         | 7.5                                 |         | 8                                   |         | ns   | 1-4            |
| txSNR  | Exit self-refresh to non-read command                | 75                                  |         | 75                                  |         | 80                                  |         | ns   | 1-4            |
| txSRD  | Exit self-refresh to read command                    | 200                                 |         | 200                                 |         | 200                                 |         | tCK  | 1-4            |
| tREFI  | Average Periodic Refresh Interval                    |                                     | 7.8     |                                     | 7.8     |                                     | 7.8     | μs   | 1-4, 8         |

## AC Timing Specification Notes

- Input slew rate = 1V/ns.
- The CK/ $\overline{\text{CK}}$  input reference level (for timing reference to CK/CK) is the point at which CK and  $\overline{\text{CK}}$  cross: the input reference level for signals other than CK/ $\overline{\text{CK}}$  is VREF.
- Inputs are not recognized as valid until VREF stabilizes.
- The Output timing reference level, as measured at the timing reference point indicated in AC Characteristics (Note 3) is VTT.
- tHZ and tLZ transitions occur in the same access time windows as valid data transitions. These parameters are not referred to a specific voltage level, but specify when the device is no longer driving (HZ), or begins driving (LZ).
- The maximum limit for this parameter is not a device limit. The device operates with a greater value for this parameter, but system performance (bus turnaround) degrades accordingly.
- The specific requirement is that DQS be valid (high, low, or some point on a valid transition) on or before this CK edge. A valid transition is defined as monotonic and meeting the input slew rate specifications of the device. When no writes were previously in progress on the bus, DQS will be transitioning from Hi-Z to logic LOW. If a previous write was in progress, DQS could be HIGH, LOW, or transitioning from high to low at this time, depending on tDQSS.
- A maximum of eight Auto refresh commands can be posted to any given DDR SDRAM device.
- For command/address input slew rate  $\geq 1.0$  V/ns. Slew rate is measured between VOH (AC) and VOL (AC).
- For command/address input slew rate  $\geq 0.5$  V/ns and  $< 1.0$  V/ns. Slew rate is measured between VOH (AC) and VOL (AC).
- CK/ $\overline{\text{CK}}$  slew rates are  $\geq 1.0$  V/ns.
- These parameters guarantee device timing, but they are not necessarily tested on each device, and they may be guaranteed by design or tester characterization.
- For each of the terms in parentheses, if not already an integer, round to the next highest integer. tCK is equal to the actual system clock cycle time. For example, for PC2100 at CL= 2.5, tDAL = (15ns/7.5ns) + (20ns/7.0ns) = 2 + 3 = 5.
- An input setup and hold time derating table is used to increase tIS and tIH in the case where the input slew rate is below 0.5 V/ns.

| Input Slew Rate | Delta (tIS) | Delta (tIH) | Unit | Note |
|-----------------|-------------|-------------|------|------|
| 0.5 V/ns        | 0           | 0           | ps   | 1, 2 |
| 0.4 V/ns        | +50         | 0           | ps   | 1, 2 |
| 0.3 V/ns        | +100        | 0           | ps   | 1, 2 |

- Input slew rate is based on the lesser of the slew rates determined by either V<sub>IH</sub> (AC) to V<sub>IL</sub> (AC) or V<sub>IH</sub> (DC) to V<sub>IL</sub> (DC), similarly for rising transitions.
- These derating parameters may be guaranteed by design or tester characterization and are not necessarily tested on each device.

- An input setup and hold time derating table is used to increase tDS and tDH in the case where the I/O slew rate is below 0.5 V/ns.

| Input Slew Rate | Delta (tDS) | Delta (tDH) | Unit | Note |
|-----------------|-------------|-------------|------|------|
| 0.5 V/ns        | 0           | 0           | ps   | 1, 2 |
| 0.4 V/ns        | +75         | +75         | ps   | 1, 2 |
| 0.3 V/ns        | +150        | +150        | ps   | 1, 2 |

- I/O slew rate is based on the lesser of the slew rates determined by either V<sub>IH</sub> (AC) to V<sub>IL</sub> (AC) or V<sub>IH</sub> (DC) to V<sub>IL</sub> (DC), similarly for rising transitions.
- These derating parameters may be guaranteed by design or tester characterization and are not necessarily tested on each device.

- An I/O Delta Rise, Fall Derating table is used to increase tDS and tDH in the case where DQ, DM, and DQS slew rates differ.

| Delta Rise and Fall Rate | Delta (tDS) | Delta (tDH) | Unit | Note |
|--------------------------|-------------|-------------|------|------|
| 0.0 ns/V                 | 0           | 0           | ps   | 1-4  |
| 0.25 ns/V                | +50         | +50         | ps   | 1-4  |
| 0.5 ns/V                 | +100        | +100        | ps   | 1-4  |

- Input slew rate is based on the lesser of the slew rates determined by either V<sub>IH</sub> (AC) to V<sub>IL</sub> (AC) or V<sub>IH</sub> (DC) to V<sub>IL</sub> (DC), similarly for rising transitions.
- Input slew rate is based on the larger of AC to AC delta rise, fall rate and DC to DC delta rise, fall rate.
- The delta rise, fall rate is calculated as:  $[1/(\text{slew rate } 1)] - [1/(\text{slew rate } 2)]$   
For example: slew rate 1 = 0.5 V/ns; slew rate 2 = 0.4 V/ns. Delta rise, fall =  $(1/0.5) - (1/0.4)$  [ns/V] = -0.5 ns/V  
Using the table above, this would result in an increase in tDS and tDH of 100 ps.
- These derating parameters may be guaranteed by design or tester characterization and are not necessarily tested on each device.



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## Revision Log

| Rev | Date    | Modification                                                                |
|-----|---------|-----------------------------------------------------------------------------|
| 0.1 | 08/2002 | Preliminary Release                                                         |
| 0.2 | 09/2002 | Added $t_{PDEX}$ (Power down exit time) to AC Timing Table                  |
| 0.3 | 09/2002 | Updated SPD Table bytes 27, 29, and 63 for DDR200                           |
|     | 11/2002 | Updated $I_{DD}$ currents in Operating, Standby, and Refresh Currents Table |
| 1.0 | 11/2002 | Official Release                                                            |
| 1.1 | 12/2002 | Fixed Package Dimensions                                                    |